

P-Channel Enhancement Mode Power MOSFET

Description

The HM3401C uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$, This device is suitable for use as a load switch or in PWM applications.

General Features

• $V_{DS} = -30V, I_D = -2.5A$

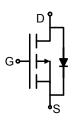
 $R_{DS(ON)}$ < 130m Ω @ V_{GS} =-10V

 $R_{DS(ON)}$ < 180m Ω @ V_{GS} =-4.5V

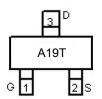
- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- PWM applications
- Load switch
- Power management



Schematic diagram



Marking and pin assignment



SOT-23 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM3401C	A19T	SOT-23	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	-30	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous	I _D	-2.5	Α	
Drain Current-Pulsed (Note 1)	I _{DM}	-10	Α	
Maximum Power Dissipation	P _D	1.0	W	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	°C	

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ hetaJA}$	125	°C/W

Electrical Characteristics (T_A=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-30	-33	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-30V,V _{GS} =0V	-	-	-1	μA



Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA	
On Characteristics (Note 3)	•		•	•			
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-1	-1.6	-2.5	V	
Drain Course On Ctata Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-2.5A	-	72	130	mΩ	
Drain-Source On-State Resistance		V _{GS} =-4.5V, I _D =-1.5A	-	110	180	mΩ	
Forward Transconductance	g FS	V _{DS} =-10V,I _D =-2A		2	-	S	
Dynamic Characteristics (Note4)	•		•	•			
Input Capacitance	C _{lss}	\/ - 45\/\/ -0\/	-	226	-	PF	
Output Capacitance	Coss	V_{DS} =-15V, V_{GS} =0V,	-	47	-	PF	
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz		28	-	PF	
Switching Characteristics (Note 4)	Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	9	-	nS	
Turn-on Rise Time	t _r	V_{DD} =-15V, R_L =15 Ω	-	9	-	nS	
Turn-Off Delay Time	t _{d(off)}	V_{GS} =-10V, R_{GEN} =6 Ω	-	18	-	nS	
Turn-Off Fall Time	t _f		-	6	-	nS	
Total Gate Charge	Qg		-	8.5	-	nC	
Gate-Source Charge	Q _{gs}	V _{DS} =-15V,I _D =-2.0A,V _{GS} =-10V	-	2.3	-	nC	
Gate-Drain Charge	Q _{gd}		-	1.5	-	nC	
Drain-Source Diode Characteristics	1	•	1	1		•	
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-2.5A	-	-	-1.2	V	

Notes:

- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature.}$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics

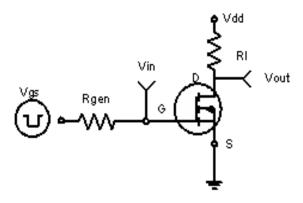


Figure 1:Switching Test Circuit

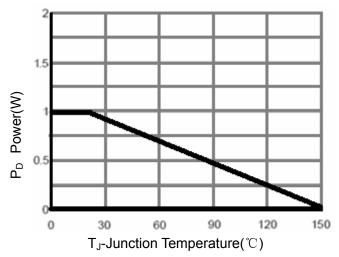


Figure 3 Power Dissipation

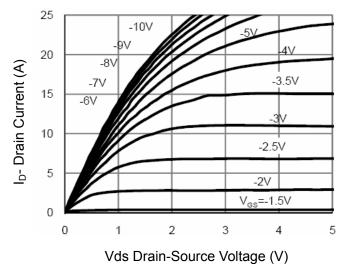


Figure 5 Output Characteristics

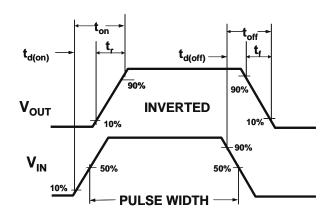


Figure 2:Switching Waveforms

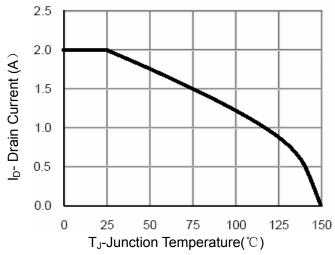


Figure 4 Drain Current

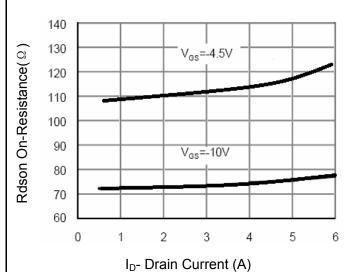
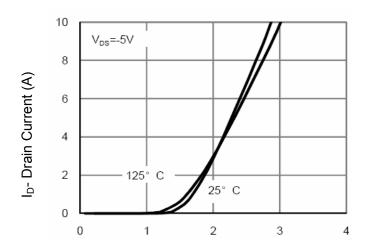
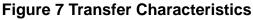


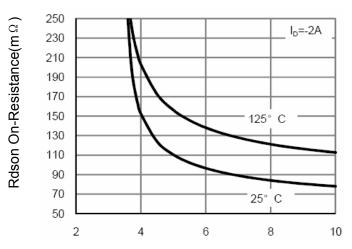
Figure 6 Drain-Source On-Resistance





Vgs Gate-Source Voltage (V)





Vgs Gate-Source Voltage (V)

Figure 9 Rdson vs Vgs

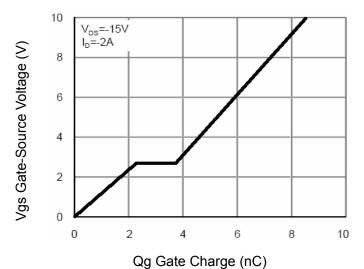
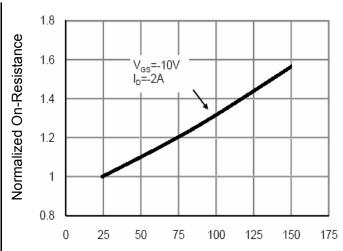
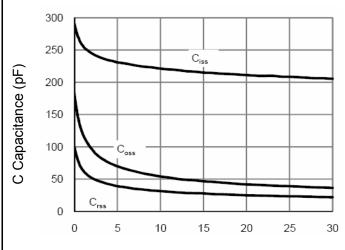


Figure 11 Gate Charge



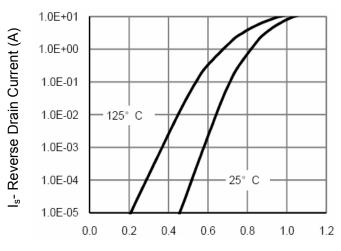
 T_J -Junction Temperature($^{\circ}$ C)





Vds Drain-Source Voltage (V)

Figure 10 Capacitance vs Vds



Vsd Source-Drain Voltage (V)

Figure 12 Source- Drain Diode Forward



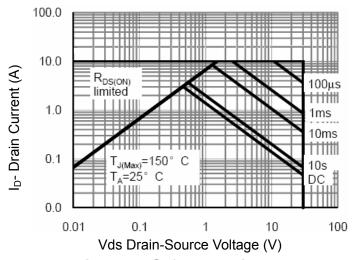


Figure 13 Safe Operation Area

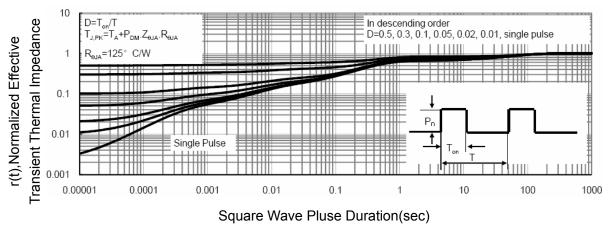
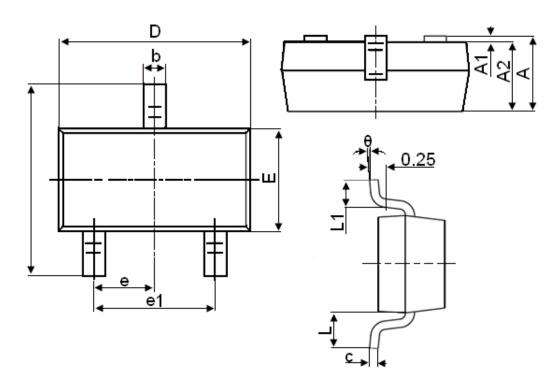


Figure 14 Normalized Maximum Transient Thermal Impedance



SOT-23 Package Information



Symbol	Dimensions in Millimeters				
Symbol	MIN.	MAX.			
Α	0.900	1.150			
A1	0.000	0.100			
A2	0.900	1.050			
b	0.300	0.500			
С	0.080	0.150			
D	2.800	3.000			
Е	1.200	1.400			
E1	2.250	2.550			
е		0.950TYP			
e1	1.800	2.000			
L		0.550REF			
L1	0.300	0.500			
θ	0°	8°			

Notes

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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